TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type ($L^2-\pi$ -MOSV)

2SK2231

Chopper Regulator, DC/DC Converter and Motor Drive Applications

- 4 V gate drive
- Low drain-source ON-resistance $: R_{DS (ON)} = 0.12 \Omega (typ.)$
- High forward transfer admittance $: |Y_{fs}| = 5.0 \text{ S (typ.)}$
- Low leakage current : I_{DSS} = 100 μA (max) (V_{DS} = 60 V)
- Enhancement mode : $V_{th} = 0.8 \sim 2.0 \text{ V} (V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Character	istic	Symbol	Rating	Unit
Drain-source voltage		V _{DSS}	60	V
Drain-gate voltage (R	_{GS} = 20 kΩ)	V _{DGR}	60	V
Gate-source voltage		V _{GSS}	±20	V
Drain current	DC (Note 1)	۱ _D	5	А
	Pulse (Note 1)	I _{DP}	20	А
Drain power dissipatio	n (Tc = 25°C)	PD	20	W
Single-pulse avalanch	e energy (Note 2)	E _{AS}	129	mJ
Avalanche current		I _{AR}	5	А
Repetitive avalanche e	energy (Note 3)	E _{AR}	2	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature r	ange	T _{stg}	-55~150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Thermal Characteristics

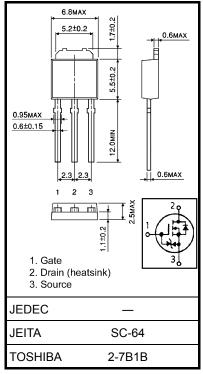
Characteristic	Symbol	Мах	Unit
Thermal resistance, channel to case	R _{th (ch−c)}	6.25	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	125	°C / W

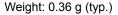
Note 1: Ensure that the channel temperature does not exceed 150°C.

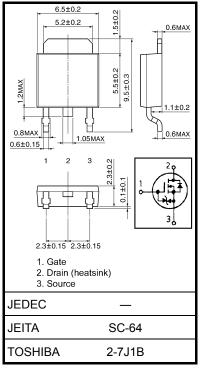
Note 2: V_{DD} = 25 V, T_{ch} = 25°C (initial), L = 7 mH, R_G = 25 Ω , I_{AR} = 5 A

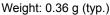
Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.









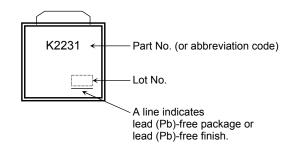
Electrical Characteristics (Ta = 25°C)

Chara	cteristic	Symbol	Test Condition	Min	Тур.	Мах	Unit	
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V			±10	μA	
Drain cutoff curr	ent	IDSS	V _{DS} = 60 V, V _{GS} = 0 V	_	_	100	μA	
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	60		_	V	
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V	
Drain-source ON-resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 1.3 A	—	0.20	0.30	Ω	
			V _{GS} = 10 V, I _D = 2.5 A	—	0.12	0.16		
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 2.5 A	3.0	5.0		S	
Input capacitance	ce	C _{iss}		_	370	_		
Reverse transfer capacitance		C _{rss}	C _{rss} V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		60	_	pF	
Output capacitance		C _{oss}		_	180	_		
Switching time	Rise time	tr	$v_{GS} \stackrel{10V}{}_{0V} \int I_{D} = 2.5A$ $v_{GS} \stackrel{0V}{}_{0V} \int I_{D} = 2.5A$ $R_{L} = 12\Omega$ $V_{DD} = 30V$	_	18	_		
	Turn-on time	t _{on}		_	25	_		
	Fall time	t _f		_	55	_	ns	
	Turn-off time	t _{off}	Duty $\leq 1\%$, t _w = 10 μ s	_	170	_		
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈ 48 V, V _{GS} = 10 V, I _D = 5 A		12	_		
Gate-source charge		Q _{gs}			8	_	nC	
Gate-drain ("Miller") charge		Q _{gd}			4			

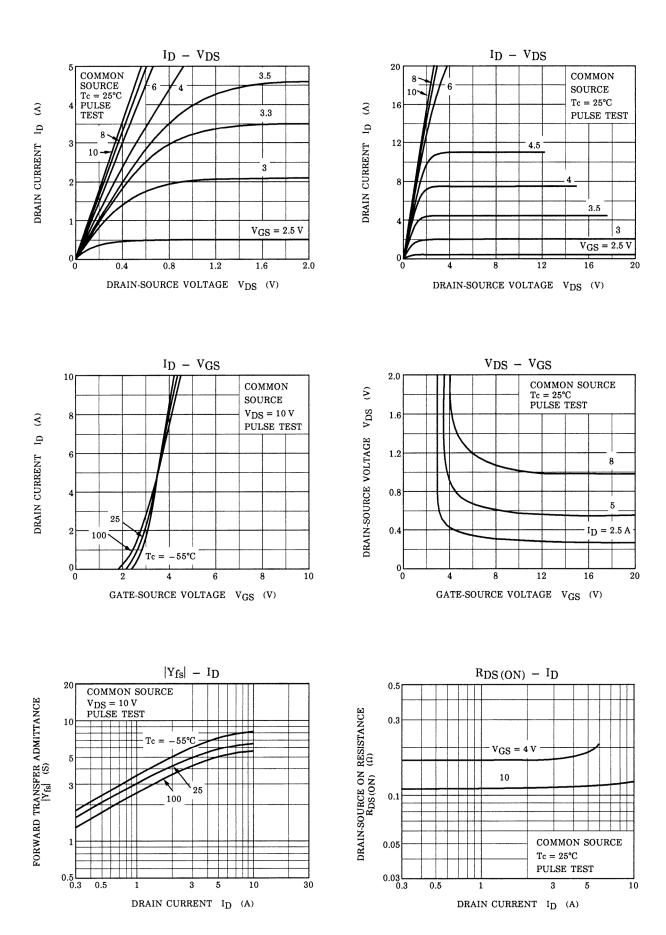
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	5	А
Pulse drain reverse current (Note 1)	I _{DRP}	_	_		20	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 5 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	-I _{DR} = 5 A, V _{GS} = 0 V, dI _{DR} / dt = 50 A / μs	_	70	_	ns
Reverse recovery charge	Q _{rr}		_	0.1	_	μC

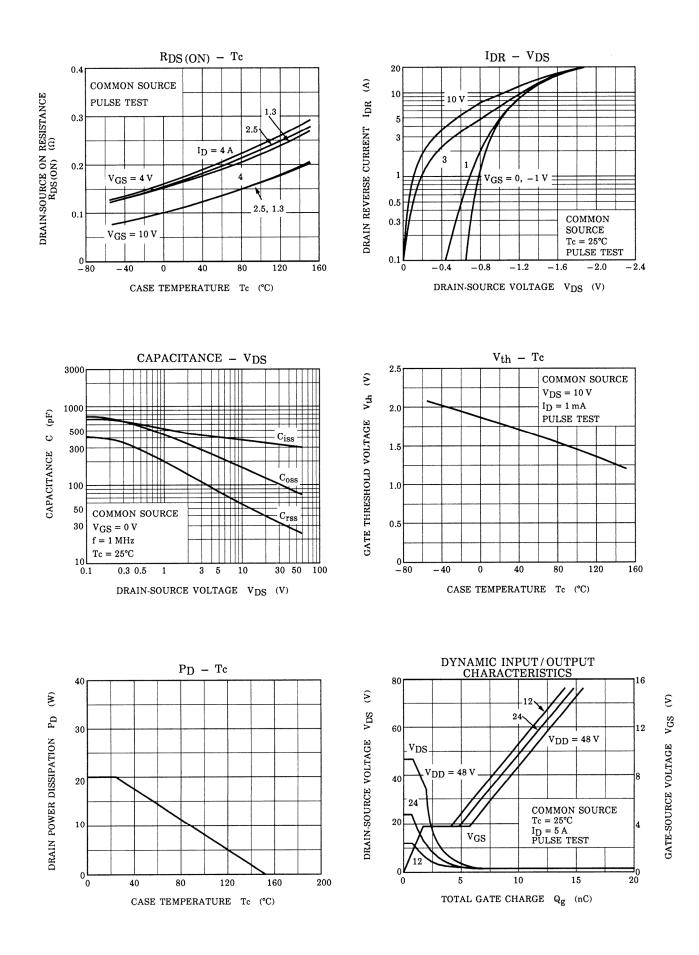
Marking

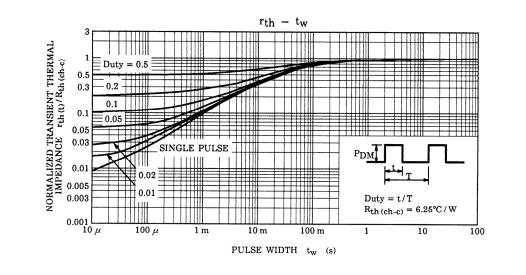


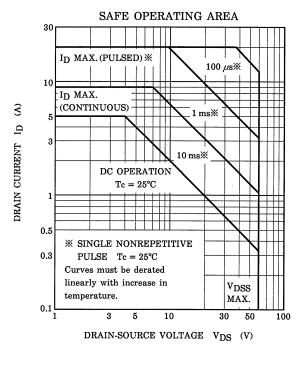
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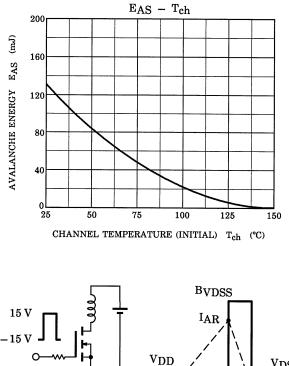


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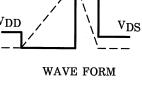






TEST CIRCUIT

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 $\begin{aligned} \mathrm{R}_{\mathrm{G}} &= 25 \ \Omega \\ \mathrm{V}_{\mathrm{DD}} &= 25 \ \mathrm{V}, \ \mathrm{L} &= 7 \ \mathrm{mH} \end{aligned} \qquad \qquad \mathrm{E}_{\mathrm{AS}} &= \frac{1}{2} \cdot \mathrm{L} \cdot \mathrm{I}^2 \cdot \left(\frac{\mathrm{B}_{\mathrm{VDSS}}}{\mathrm{B}_{\mathrm{VDSS}} - \mathrm{V}_{\mathrm{DD}}} \right) \end{aligned}$

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